

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10561610	NAGANO ET AL.
Examiner	Art Unit	
Hsieh, Ping Y	2618	

### SEARCHED

Class	Subclass	Date	Examiner
455	62,63,3,78,82,83,63.1	9/8/08	PH

### SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Yuwen Pan	12/06/07	PH
Text search in EAST (see search history)	9/8/08	PH
PLUS search	12/06/07	PH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	see interference search	9/8/08	PH

/P. Y. H./  
Examiner.Alt Unit 2618